

Search Notes**Application/Control No.**

10/660,950

Examiner

Maikhhanh Nguyen

Applicant(s)/Patent under Reexamination

O'DONNELL, SHAWN

Art Unit

2176

SEARCHED

Class	Subclass	Date	Examiner
715	505	10/22/2005	MK
715	506,507	10/22/2005	MK
707	10	10/22/2005	MK
Updated	above	5/16/2006	MK
Updated	above	2/19/2007	MK
Updated	above	1/18/2008	MK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	10/22/2005	MK
West Search	10/22/2005	MK
NPL (IEEE)	10/22/2005	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout	5/16/2006	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout	2/19/2007	MK
West Updated (USPAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB) See Search History Printout	1/18/2008	MK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner